# TOSHIBA

Unit: mm

TOSHIBA Power Transistor Module Silicon PNP Epitaxial Type (Darlington power transistor 4 in 1)

# MP4305

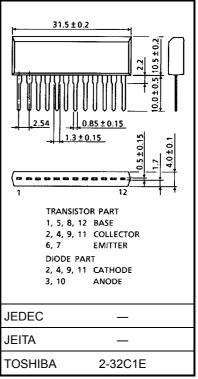
High Power Switching Applications.

Hammer Drive, Pulse Motor Drive and Inductive Load Switching.

- Small package by full molding (SIP 12 pin)
- High collector power dissipation (4 devices operation)  $: P_T = 4.4 \text{ W} \text{ (Ta} = 25^{\circ}\text{C)}$
- High collector current:  $I_{C}$  (DC) = -5 A (max)
- High DC current gain:  $h_{FE} = 2000$  (min) ( $V_{CE} = -5 V$ ,  $I_C = -3 A$ )
- Diode included for absorbing fly-back voltage.

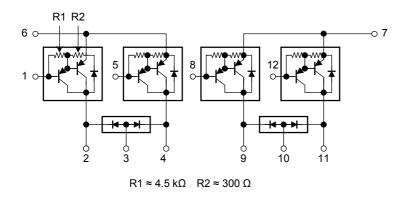
#### Maximum Ratings (Ta = 25°C)

Characteristics		Symbol	Rating	Unit
Collector-base voltage		V <sub>CBO</sub>	-100	V
Collector-emitter voltage		V <sub>CEO</sub>	-100	V
Emitter-base voltage		V <sub>EBO</sub>	-6	V
Collector current	DC	Ι <sub>C</sub>	-5	Α
	Pulse	I <sub>CP</sub>	-8	A .
Continuous base current		I <sub>B</sub>	-0.5	А
Collector power dissipation (1 device operation)		Pc	2.2	W
Collector power dissipation (4 devices operation)		PT	4.4	W
Junction temperature		Tj	150	°C
Storage temperature range		T <sub>stg</sub>	-55 to 150	°C



Weight: 3.9 g (typ.)

### Array Configuration



Industrial Applications

#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit	
Thermal resistance of junction to ambient	ΣR <sub>th (j-a)</sub>	28.4	°C/W	
(4 devices operation, Ta = 25°C)	· · · ·			
Maximum lead temperature for soldering purposes	TL	260	°C	
(3.2 mm from case for 10 s)				

#### Electrical Characteristics (Ta = 25°C)

Charac	teristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off cu	rrent	I <sub>CBO</sub>	V <sub>CB</sub> = -100 V, I <sub>E</sub> = 0 A	_	_	-10	μA
Collector cut-off cu	rrent	ICEO	V <sub>CE</sub> = -100 V, I <sub>B</sub> = 0 A	_	_	-10	μA
Emitter cut-off curr	ent	I <sub>EBO</sub>	$V_{EB} = -6 V, I_C = 0 A$	-0.6	_	-2.0	mA
Collector-base brea	akdown voltage	V (BR) CBO	I <sub>C</sub> = −1 mA, I <sub>E</sub> = 0 A	-100	_	_	V
Collector-emitter b	reakdown voltage	V (BR) CEO	I <sub>C</sub> = −10 mA, I <sub>B</sub> = 0 A	-100	_	_	V
		h <sub>FE (1)</sub>	$V_{CE} = -5 V, I_C = -3 A$	2000	_	15000	
DC current gain	h <sub>FE (2)</sub>	$V_{CE} = -5 V, I_C = -5 A$	1000	_	_		
Caturation voltage	Collector-emitter	V <sub>CE (sat)</sub>	I <sub>C</sub> = -3 A, I <sub>B</sub> = -6 mA	_	_	-1.5	v
Saturation voltage	Base-emitter	V <sub>BE (sat)</sub>	I <sub>C</sub> = -3 A, I <sub>B</sub> = -6 mA	_	_	-2.0	v
Transition frequency		f <sub>T</sub>	$V_{CE} = -2 V, I_C = -0.5 A$	_	40	_	MHz
Collector output capacitance		C <sub>ob</sub>	V <sub>CB</sub> = -10 V, I <sub>E</sub> = 0 A, f = 1 MHz	_	55	_	pF
Turn-on time      Switching time      Storage time      Fall time	Turn-on time	t <sub>on</sub>	- ☐ Output Input B2 □ □ □ □ □ □ □ □ □ □ □ □ □ □ □ □ □ □ □	_	0.3	_	
	Storage time	t <sub>stg</sub>		_	2.0	_	μs
	Fall time	t <sub>f</sub>	V <sub>CC</sub> = −30 V −I <sub>B1</sub> = I <sub>B2</sub> = 6 mA, duty cycle ≤ 1%	_	0.4	_	

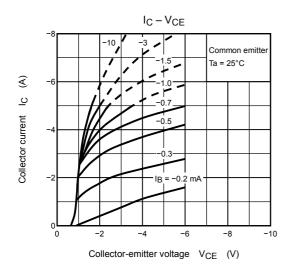
#### Emitter-Collector Diode Ratings and Characteristics (Ta = 25°C)

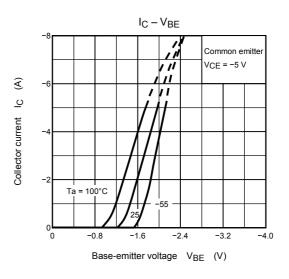
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Maximum forward current	I <sub>FM</sub>	—	_	_	3	А
Surge current	I <sub>FSM</sub>	t = 1 s, 1 shot	_	_	6	А
Forward voltage	VF	I <sub>F</sub> = 1 A, I <sub>B</sub> = 0 A	_	_	2.0	V
Reverse recovery time	t <sub>rr</sub>	I <sub>F</sub> = 3 A, V <sub>BE</sub> = 3 V, dI <sub>F</sub> /dt = −50 A/µs	_	1.0	_	μs
Reverse recovery charge	Q <sub>rr</sub>			8	_	μC

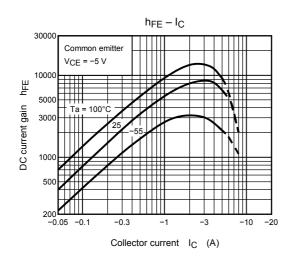
## Flyback-Diode Rating and Characteristics (Ta = 25°C)

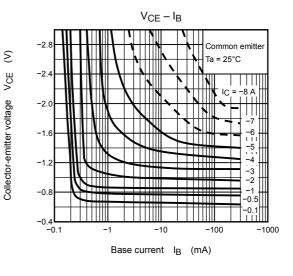
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Maximum forward current	I <sub>FM</sub>	—	_	_	3	А
Reverse current	I <sub>R</sub>	V <sub>R</sub> = 110 V	_	_	0.4	μA
Reverse voltage	V <sub>R</sub>	I <sub>R</sub> = 100 μA	100	-	_	V
Forward voltage	V <sub>F</sub>	I <sub>F</sub> = 1 A	_	_	1.5	V

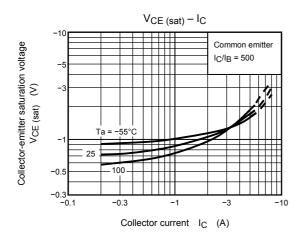
## **TOSHIBA**

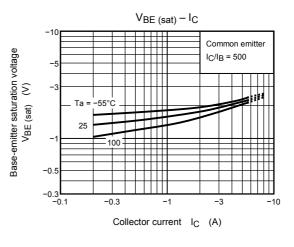


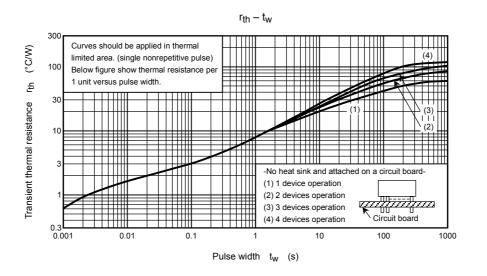


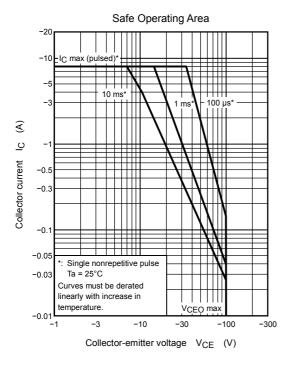




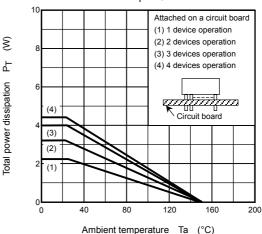


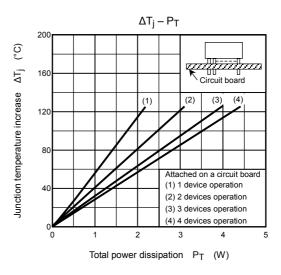












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